

Notice of References Cited	Application/Control No. 10/500,486	Applicant(s)/Patent Under Reexamination IRIKUCHI ET AL.	
	Examiner DANIEL TEKLE	Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0092021	07-2002	Yap et al.	725/55
*	B	US-6,405,372	06-2002	Kim et al.	725/50
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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